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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application of

YAMADA et al

Atty. Ref.: 2018-834

Serial No. 10/761,377

TC/A.U.: 2857

Filed: January 22, 2004

Examiner:

For: ELECTRONIC CONTROL UNIT

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May 21, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

Attention is directed to the attached EPO Search Report for a counterpart of this application and each reference cited therein. A PTO-1449 is also attached.

Official consideration and citation of each such reference is requested.

Respectfully submitted,

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Ву:

Pag No. 25 640

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INFORMATION DISCLOSURE		ATTY. DOCKET NO.		' SERIAL	_ NO.				
CITATION		2018-834		10/76	51,377				
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		U.S. PATEN	T DOCUMENTS						
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	5440487	08/1995	Althoff et al						
	5550736	08/1996	Hay et al						
	5654888	08/1997	Muller et al	_					
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	DOCUMENT	DATE	COUNTRY	•	CLASS	SUBCLASS	TRANS YES	LATIO	
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-	0575854 A2	12/1993	Europe			 		 	
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Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

Date Considered

*Examiner